

# SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS PRODUCT SPECIFICATION 規格書

CUSTOMER: (客戶): DATE: (日期):2017-08-03

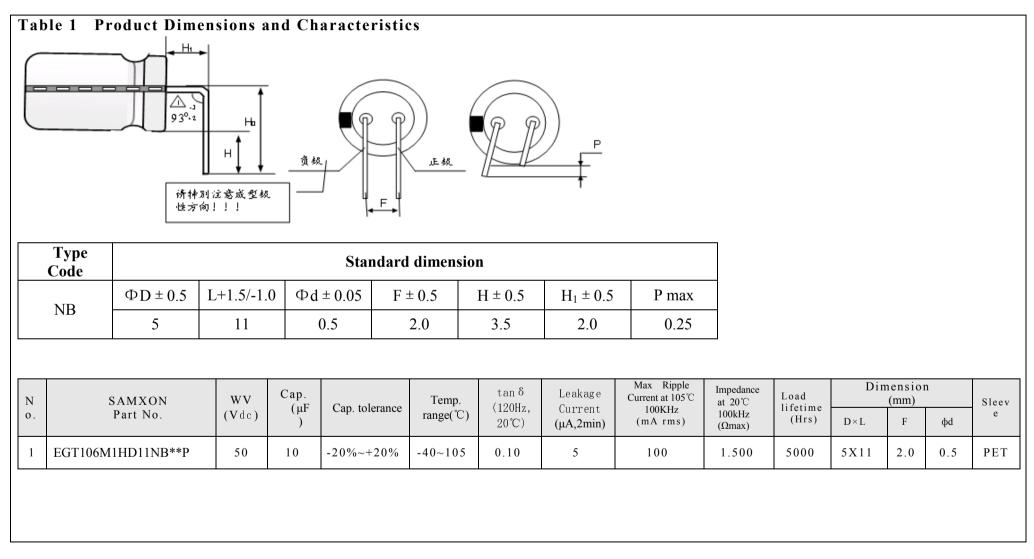
CATEGORY (品名)	: ALUMINUM ELECTROLYTIC CAPACITORS
DESCRIPTION (型号)	: GT $50V10\mu F(\varphi 5x11)$
VERSION (版本)	: 01
Customer P/N	:
SUPPLIER	:

SUPPLIER			CUST	OMER
PREPARED (拟定)	CHECKED (审核)	APPROVA (批准)	AL .	SIGNATURE (签名)
李婷	刘渭清			

# ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

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# ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES



# 1. Application

This specification applies to polar Aluminum electrolytic capacitor (foil type) used in electronic equipment. Designed capacitor's quality meets IEC60384.

### Part Number System 2. 7 123 4 5 6 89 101112 1314 1516 17 D P EGS 1 0 5 М 1 H 1 1 тс S Α SERIES CAPACITANCE TOL VOLTAGE CASE SIZE SLEEVE SAMXON SLEEVE PRODUCT LINE MATERIAL TYPE Code Tolerance (%) Code Cap(MFD) Voltage (W.V.) Code Case Size Feature Code SAMXON Product Lin Case 5126 Diameter(#) Code 3 B 3.5 1 4 C 5 D 6.3 E 8 F 10 G 12.5 1 13 J ESM EKF ESS EKS 0D 2 For internal use only Radial bulk RR 104 0.1 ±5 J 2.5 0E (The product lines 4 0G we have H,A,B,C,D, Ammo Taping 0.22 224 G ±10 к 6.3 OJ E,M or 0,1,2,3,4,5,9). EKM EKG EOM 8 0K 0.33 2.0mm Pitch тτ 334 10 1A ± 15 L 12.5 1B JV4AK7 τυ ZS EGF ESF EG 2.5mm Pitch 0.47 474 13.5 14 16 1C Μ 20 1D ±20 тν 1 105 14.5 3.5mm Pitch Sleeve Ma 25 1E EGK EGE EGD EGC 16 16.5 18 30 11 5.0mm Pitch тс PET Р 18 18 20 22 25 30 34 35 42 42 51 2.2 225 Ν +3032 13 1V Lead Cut & Form 35 ERS 3.3 335 -40 w 40 1G СВ 42 1**M** CB-Type 475 4.7 -20 Α 50 1H CE-Type CE 57 1L 106 10 ERI ERI EBI -20 +10 63 1J С HE-Type HE 226 45 51 53.5 76 80 90 100 1S 22 71 ERA ERB ERC 1**T** 75 6 -20 +40 х KD-Type КD 33 336 80 1K 85 1R -20 +50 ENF ENF ERV ERV s FD-Type FD 47 476 19 90 100 2A 4.5 5 5.4 45 EH-Type EH -10 107 в 100 05 54 07 77 120 20 2B 125 PCB Termial 220 227 -10 +20 v 7. 10.2 11 5 150 27 160 2G sw 330 337 -10 +30 0 180 $2\mathbf{P}$ EUP 2D 200 Snap-in sx 470 477 -10 +50 12 т 215 22 220 2N 13.5 sz 2200 228 ESF -5 +10 230 23 20 Е Lug SG 250 2E 29.5 22000 229 -5 +15 275 2T F 3 05 300 21 1.5 33000 339 35 35.5 50 100 105 110 120 120 -5 +20 310 2R G 06 315 2F 47000 479 330 2U 0 +20 R Т5 350 2V 100000 10T Screw 0 +30 360 2X 0 Т6 375 2Q 150000 15T 0 +50 385 2Y I D5 400 2G 220000 22T +5 +15 420 2M z D6 450 2W 330000 33T +5 500 2H D 550 25 1000000 10M +10+50 Y 600 26 630 2J 1500000 15M +10 н 2200000 22M 3300000 33M 5

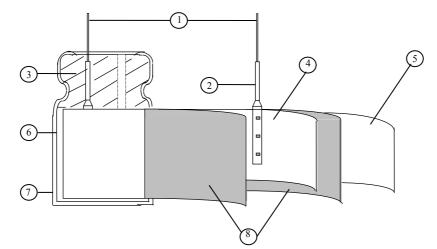
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# 3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	РЕТ
8	Separator	Electrolyte paper

# 4. Characteristics

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature	:15°C to 35°C
Relative humidity	: 45% to 85%
Air Pressure	: 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature	$: 20^{\circ}C \pm 2^{\circ}C$
Relative humidity	: 60% to 70%
Air Pressure	: 86kPa to 106kPa

# Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

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# ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES



	ITEM				PERFO	RMANC	Ъ			
	Rated voltage									
	(WV)	WV (V.DC)	6.3	10	16	25	35	50	63	100
4.1		SV (V.DC)	8	13	20	31	44	63	79	125
	Surge voltage (SV)							1	1	
4.2	Nominal capacitance (Tolerance)	Condition> Measuring F Measuring V Measuring T <criteria> Shall be with</criteria>	requency oltage 'emperati	: No ure : 20	±2℃	han 0.5V				
4.3	Leakage current	Condition> Connecting t minutes, and <criteria> Refer to Table</criteria>	he capac then, me				istor (1	$k\Omega \pm 10$	Ω) in so	eries for 2
4.4	tan δ	<condition> See 4.2, Norr <criteria> Refer to Table</criteria></condition>	m Capac	itance, fo	r measur	ing frequ	iency, vo	oltage and	l tempera	ture.
4.5	Terminal strength		ength of capacitor rength of apacitor,	, applied Termina applied fo nds, and d wire	force to ls. force to b then ber Tens	ent the te	rminal ( 0° to its	l~4 mm t original j Bending (ka	from the position v	rubber) fo

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		<condition> STEP</condition>	Testi	ng Tempe	ratura(°C`			Time		
		<u> </u>	Testi	$\frac{100}{20\pm 2}$			to reach		auilibri	
		2					to reach		-	
		3		-40(-25) 20±2			to reach			
									<b>`</b>	
		4		$105\pm$			to reach		1	
		5		$20\pm 2$	2	Time	to reach	thermal	equilibri	um
		< <b>Criteria&gt;</b> a. tan δ shall	ha with	in the lim	it of Itom	1 ATha l	alzaga a	rrant ma	agurad a	hall not
		more than 8 tir				4.4111010	cakage ci		asureu s	siidii iiot
	Temperature	b. In step 5, ta		-		nit of Iter	n 4 4The	leakage	current	shall not
	characteristi	more than the						100110080	••••••••••	511111 110 0
4.6	cs	c. At-40°C (-2			(z) ratio	hall not o	exceed th	e value o	of the fol	llowing
		table.		1	< <i>/</i>					e
		Working Voltag	ge (V)	6.3	10	16	25	35	50	63
		Z-25°C/Z+20	0°C	4	3	2	2	2	2	2
		Z-40°C/Z+20	0°C	8	6	4	3	3	3	3
		XX7 1 X7 1		100						
		Working Voltag		100						
		$Z-25^{\circ}C/Z+20$		2						
		Z-40°C/Z+20		3	Г. А.11.0.	_	1 1000			<b>2</b> 0°C
		For capacitance	e value	$> 1000 \mu$	F. Add U.	o per ano	ther 1000	JUHTOr	L-23/L+	-20 C
						-				
		Canacitance tar	n San	d imnadar	Add 1.0	) per anot	her 1000	μF for Z		
		Capacitance, tar	n <sup>δ</sup> , and	d impedan	Add 1.0	) per anot	her 1000	μF for Z		
		<condition></condition>		-	Add 1.0	) per anot e measur	her 1000 ed at 120	μ F for Z Hz.	Z-40°C/2	Z+20°C.
		<condition> According to II</condition>	EC6038	34-4No.4.	Add 1.0 ace shall b 13 method	b per anot e measur	her 1000 ed at 120 pacitor is	μ F for Z Hz.	Z-40°C/Z	Z+20°C.
		<pre><condition> According to II 105°C ±2 with</condition></pre>	EC6038 h DC bi	34-4No.4. as voltage	Add 1.0 ace shall b 13 method plus the	b per anot e measur ls, The ca rated ripp	her 1000 ed at 120 pacitor is le curren	μ F for Z Hz. s stored a t for Tab	Z-40°C/Z	Z+20°C. erature of he sum of
		Condition> According to II 105°C ±2 with DC and ripple	EC6038 h DC bi	34-4No.4. as voltage voltage sh	Add 1.0 ace shall b 13 method plus the mall not estimated	l per anot e measur ls, The ca rated ripp cceed the	her 1000 ed at 120 pacitor is le curren e rated w	μ F for Z Hz. s stored a t for Tab vorking x	Z-40°C/2 at a temp ble 1. (T voltage)	Z+20°C. erature of he sum of Then the
	Lond	Condition> According to II 105°C ±2 with DC and ripple product should	EC6038 h DC bi peak	34-4No.4. as voltage voltage sh ed after 16	Add 1.0 ace shall b 13 method plus the p nall not end 6 hours red	l per anot e measur ls, The ca rated ripp cceed the	her 1000 ed at 120 pacitor is le curren e rated w	μ F for Z Hz. s stored a t for Tab vorking x	Z-40°C/2 at a temp ble 1. (T voltage)	Z+20°C. erature of he sum of Then the
4 7	Load	Condition> According to II 105°C ±2 with DC and ripple	EC6038 h DC bi peak	34-4No.4. as voltage voltage sh ed after 16	Add 1.0 ace shall b 13 method plus the p nall not end 6 hours red	l per anot e measur ls, The ca rated ripp cceed the	her 1000 ed at 120 pacitor is le curren e rated w	μ F for Z Hz. s stored a t for Tab vorking x	Z-40°C/2 at a temp ble 1. (T voltage)	Z+20°C. erature of he sum of Then the
4.7	Load life test	Condition> According to II 105°C ±2 with DC and ripple product should result should m	EC6038 h DC bi peak be test neet the	34-4No.4. as voltage voltage sh ed after 16 following	Add 1.0 ace shall b 13 method plus the p nall not en b hours rea g table:	s, The ca rated ripp cceed the	her 1000 ed at 120 pacitor is le curren e rated w time at at	μ F for Z Hz. s stored a t for Tab vorking x	Z-40°C/2 at a temp ble 1. (T voltage)	Z+20°C. erature of he sum of Then the
4.7	life	Condition> According to II 105°C ±2 with DC and ripple product should result should m <criteria></criteria>	EC6038 h DC bi be test be test neet the stic sha	34-4No.4. as voltage voltage sh ed after 16 following <u>ll meet th</u>	Add 1.0 ace shall b 13 method plus the p nall not en b hours rea g table:	s, The car ated ripp cceed the covering t	her 1000 ed at 120 pacitor is le curren e rated w time at at ments.	μ F for Z Hz. s stored a t for Tab vorking v mospher	Z-40°C/2 at a temp ble 1. (T voltage)	Z+20°C. erature of he sum of Then the
4.7	life	Condition> According to II 105°C ±2 with DC and ripple product should result should m <criteria> The characteria</criteria>	EC6038 h DC bi be testo heet the stic sha e curren	34-4No.4. as voltage voltage sh ed after 16 following Il meet the tt	Add 1.0 ace shall b 13 method plus the p nall not ex b hours read table: e followin	s, The car ated ripp cceed the covering t <u>g require</u> 4.3 shall	her 1000 ed at 120 pacitor is le curren e rated w time at at <u>ments.</u> be satisfi	μ F for Z Hz. s stored a t for Tab rorking v mospher	Z-40°C/2 at a temp ble 1. (T voltage)	Z+20°C. erature of he sum of Then the
4.7	life	<condition>According to II<math>105^{\circ}C \pm 2</math> withDC and rippleproduct shouldresult should m<criteria>The characteriaLeakage</criteria></condition>	EC6038 h DC bi be testo heet the stic sha e curren	34-4No.4. as voltage voltage sh ed after 16 following Il meet the tt	Add 1.0 ace shall b 13 method plus the p all not e: 5 hours red 5 table: e followin Value in	b per anot e measur ls, The ca rated ripp acceed the covering to g require 4.3 shall 25% of	her 1000 ed at 120 pacitor is le curren e rated w time at at ments. be satisfi initial va	μ F for Z Hz. s stored a t for Tab vorking v mospher ied ilue.	Z-40°C/2 at a temp ble 1. (T voltage) ic condi	Z+20°C. erature of he sum of Then the tions. The
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4.7	life	<condition>According to II<math>105^{\circ}C \pm 2</math> withDC and rippleproduct shouldresult should m<criteria>The characterinLeakageCapacitatan <math>\delta</math>Appeara</criteria></condition>	EC6038 h DC bi peak be test heet the stic sha curren ance Ch	34-4No.4. as voltage voltage sh ed after 16 following Il meet the tt	Add 1.0 ace shall b 13 method plus the p all not e b hours rea b hours rea b table: e followin Value in Within =	s, The car ated ripp acceed the covering the <u>g require</u> 4.3 shall <u>25% of</u> than 200	her 1000 ed at 120 pacitor is le curren e rated w time at at ments. be satisfi initial va 0% of the	μ F for Z Hz. s stored a t for Tab rorking v mospher ied ilue. specifie	Z-40°C/2 at a temp ole 1. (T voltage) ic condi	Z+20°C. erature of he sum of Then the tions. The
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		riteria>	ha fallowing requirements
	11	e characteristic shall meet t Leakage current	Value in 4.3 shall be satisfied
9	Shelf		Within $\pm 25$ of initial value.
	life	Capacitance Change	
	test	tan δ	Not more than 200% of the specified value.
	5	Appearance	There shall be no leakage of electrolyte.
		1	stored more than 1 year, the leakage current may
			through about 1 k $\Omega$ resistor, if necessary.
	Aj Ti fo T		e 15~35℃.
4.9 8	Surge	Leakage current	Not more than the specified value.
49	test	Capacitance Change	Within $\pm 15\%$ of initial value.
		tan $\delta$	Not more than the specified value.
		Appearance	There shall be no leakage of electrolyte.
	Δ	ttention:	There shall be no leakage of electrolyte.
	ov <(	rer voltage as often applied.	
4 10	bration test	rpendicular directions. Vibration frequency ran Peak to peak amplitude Sweep rate ounting method: e capacitor with diameter g place with a bracket. 4mm or less 4mm or less Eriteria> fter the test, the following it	: 1.5mm : 10Hz ~ 55Hz ~ 10Hz in about 1 minute reater than 12.5mm or longer than 25mm must be fixed Within $30^{\circ}$ To be soldered

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# ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

4.11	Solderability test	<condition>         The capacitor shall be tested under the following conditions:         Soldering temperature       : 245±3°C         Dipping depth       : 2mm         Dipping speed       : 25±2.5mm/s         Dipping time       : 3±0.5s         <criteria>       A minimum of 95% of the surface being immersed</criteria></condition>
4.12	Resistance to solder heat test	<condition> Terminals of the capacitor shall be immersed into solder bath at <math>260 \pm 5^{\circ}</math>C for <math>10 \pm</math> 1 seconds or <math>400 \pm 10^{\circ}</math>C for <math>3^{+1}_{-0}</math> seconds to <math>1.5 \sim 2.0</math>mm from the body of capacitor . Then the capacitor shall be left under the normal temperature and normal humidity for <math>1 \sim 2</math> hours before measurement.<criteria>Leakage currentNot more than the specified value. Capacitance ChangeWithin <math>\pm 10\%</math> of initial value. tan <math>\delta</math>Not more than the specified value.AppearanceThere shall be no leakage of electrolyte.</criteria></condition>
4.13	Change of temperature test	<condition> Temperature Cycle:According to IEC60384-4No.4.7methods, capacitor shall be placed in an oven, the condition according as below:TemperatureTime (1)+20°C(1)+20°C<math>\leq 3</math> Minutes(2)Rated low temperature (-40°C) (-25°C)<math>30\pm 2</math> Minutes(3)Rated high temperature (+105°C)<math>30\pm 2</math> Minutes(1) to (3)=1 cycle, total 5 cycleCriteria&gt;The characteristic shall meet the following requirementLeakage currentNot more than the specified value. tan <math>\delta</math>Not more than the specified value.AppearanceThere shall be no leakage of electrolyte.</condition>
4.14	Damp heat test	<condition>         Humidity Test:         According to IEC60384-4No.4.12 methods, capacitor shall be exposed for <math>500 \pm 8</math>         hours in an atmosphere of <math>90 \sim 95\%</math>R H .at <math>40 \pm 2\%</math>, the characteristic change shall         meet the following requirement.         <criteria>         Leakage current       Not more than the specified value.         Capacitance Change       Within <math>\pm 20\%</math> of initial value.         tan <math>\delta</math>       Not more than 120% of the specified value.         Appearance       There shall be no leakage of electrolyte.</criteria></condition>

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# ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES



4.15	Vent test	<condition>The following test only apply to those products with vent products at diameter <math>\geq \emptyset 6.3</math>D.C. testThe capacitor is connected with its polarity reversed to a DC power source. Then a current selected from below table is applied.<table 3=""><math>\overline{\text{Diameter (mm) DC Current (A)}}</math><math>22.4</math> or less 1<math>\overline{\text{Over } 22.4}</math><math>10</math></table></condition>
4.16	Maximum permissible (ripple current)	<b><condition></condition></b> The maximum permissible ripple current is the maximum A.C current at 120Hz and can be applied at maximum operating temperature Table-1 The combined value of D.C voltage and the peak A.C voltage shall not exceed the rated voltage and shall not reverse voltage. Frequency Multipliers: $\overline{Coefficient}$ $\overline{Freq.}$ $\overline{50}$ $120$ $300$ $1k$ $100k$ $\overline{Cap. (\mu F)}$ $10 \sim 33$ $0.45$ $0.55$ $0.70$ $0.90$ $1.00$

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# 5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

	Substances			
	Cadmium and cadmium compounds			
Heavy metals	Lead and lead compounds			
	Mercury and mercury compounds			
	Hexavalent chromium compounds			
	Polychlorinated biphenyls (PCB)			
Chloinated	Polychlorinated naphthalenes (PCN)			
organic	Polychlorinated terphenyls (PCT)			
compounds	Short-chain chlorinated paraffins(SCCP)			
	Other chlorinated organic compounds			
D · (1	Polybrominated biphenyls (PBB)			
Brominated	Polybrominated diphenylethers(PBDE) (including			
organic	decabromodiphenyl ether[DecaBDE])			
compounds	Other brominated organic compounds			
Tributyltin comp	pounds(TBT)			
Triphenyltin con	npounds(TPT)			
Asbestos				
Specific azo con	npounds			
Formaldehyde				
Beryllium oxide				
Beryllium copp	ber			
Specific phthalat	tes (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)			
Hydrofluorocarb	oon (HFC), Perfluorocarbon (PFC)			
Perfluorooctane	sulfonates (PFOS)			
Specific Benzoti	riazole			

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### **Attachment: Application Guidelines**

### 1.Circuit Design

- 1.1 Operating Temperature and Frequency
  - Electrolytic capacitor electrical parameters are normally specified at 20°C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.
- (1) Effects of operating temperature on electrical parameters
   a) At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
   b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
- (2) Effects of frequency on electrical parameters
  - a) At higher frequencies capacitance and impedance decrease while tanδ increases.
  - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).
- 1.2 Operating Temperature and Life Expectancy

See the file: Life calculation of aluminum electrolytic capacitor

1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

### (1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

(2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

(3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

(4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

- 1.4 Using Two or More Capacitors in Series or Parallel
- (1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

(2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

## 1.5 Capacitor Mounting Considerations

(1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

(2)Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

(3)Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

(4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

φ6.3~φ16mm:2mm minimum, φ18~φ35mm:3mm minimum, φ40mm or greater:5mm minimum.

(5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

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(6) Wiring Near the Pressure Relief Vent Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite. (7) Circuit Board patterns Under the Capacitor Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short. (8) Screw Terminal Capacitor Mounting Do not orient the capacitor with the screw terminal side of the capacitor facing downwards. Tighten the terminal and mounting bracket screws within the torque range specified in the specification. 1.6 Electrical Isolation of the Capacitor Completely isolate the capacitor as follows. (1) Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths (2) Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths. 1.7 The Product endurance should take the sample as the standard. 1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling. 1.9 Capacitor Sleeve The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor. The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures. CAUTION! Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use. (1) Provide protection circuits and protection devices to allow safe failure modes. (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure. 2.Capacitor Handling Techniques 2.1 Considerations Before Using (1) Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment. (2) Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about  $1k\Omega$ . (3) Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately  $1k\Omega$ . (4) If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors. (5) Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result. 2.2 Capacitor Insertion (1) Verify the correct capacitance and rated voltage of the capacitor. (2) Verify the correct polarity of the capacitor before inserting. (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals. (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor. For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection. 2.3 Manual Soldering (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less. (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal. (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads. (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve. 2.4 Flow Soldering (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result. (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.

- (3) Do not allow other parts or components to touch the capacitor during soldering.
- 2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

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- 2.6 Capacitor Handling after Solder
- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.
- 2.7 Circuit Board Cleaning

Acetone

- Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60°C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

- Alkali solvents : could attack and dissolve the aluminum case.
- Petroleum based solvents: deterioration of the rubber seal could result.
- Xylene : deterioration of the rubber seal could result.
  - : removal of the ink markings on the vinyl sleeve could result.
- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.
- 2.8 Mounting Adhesives and Coating Agents
  - When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

# 3. Precautions for using capacitors

- 3.1 Environmental Conditions
  - Capacitors should not be stored or used in the following environments.
- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

**3.2 Electrical Precautions** 

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

## 4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100°C temperatures. If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.
- If electrolyte or gas is ingested by month, gargle with water.
  - If electrolyte of gas is ingested by month, gargie with water.

### 5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a 1000 $\Omega$ , current limiting resistor for a time period of 30 minutes. If the expired date of products date code is over eighteen months, the products should be return to confirmation.

5.1 Environmental Conditions

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The capacitor shall be not use in the following condition:

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

# 6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.